본질 집중 깊은 사고

새로운 시도 집요한 실행

정직과 신의

TOF Validation

CTO Software개발1팀



Infineon 기준 validation 항목		SONY 기준 validation 항목	
Meaning	Validation Item	Validation Item	Meaning
std(amplitude)	amplitude_std		
mean(amplitude)	amplitude_mean		
max(amplitude)	amplitude_max		
min(amplitude)	amplitude_min		
mean(depth-fitted_plane)	depth_precision_spatial		
mean(depth – GT)	single_shot_depth_error		
std(depth)	depth_precision_temporal	Depth Noise	mean(depth_std) # in ROI 10x10
std(depth) # in ROI 5x5	center noise		
mean(depth – GT)	depth_accuracy	Depth Error	mean(depth-GT) # in ROI 10x10
mean(depth – GT)/GT	depth_accuracy_percent		
the number of calibrated pixels (non-masked)	number_of _calibrated_pixels_in_roi		
number_of_calibrated_pixels_in_roi / number_of_pixels_in_roi	valid_pixels_percentages		
the top 10% of (depth – fitted_plane)	Q90norm		
max(depth – fitted plane)	plane_error_max		
mean(depth – fitted_plane)	plane_error_mean		
std(depth – fitted_plane)	plane_error_std		
angle of plane fit about y-axis	plane_tilt_angle		
angle of plane fit about x-axis	plane_pan_angle		
		DENU	std(depth – GT) # in ROI 50x50
		DNR	mean(depth_std/depth) # in ROI 10x10
		DNNU	std(depth_std/depth) # in ROI 50x50
		SAD	mean(depth – GT)
		SAD 10	mean(depth-GT) # in ROI 10x10
		depthAvg	mean(depth)
		depthMin	min(depth)
		depthMax	max(depth)

Figure







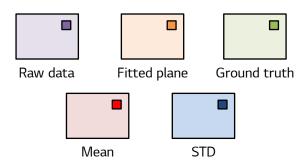
1 frame

ROI of image

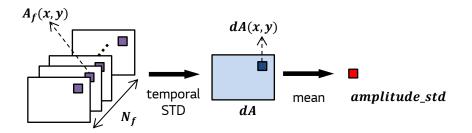
Common Parameters

- N_f : the number of frames
- w: width
- h: height
- w_{ROI} : width of ROI
- h_{ROI} : height of ROI
- x_{ROI} : start x position of ROI
- y_{ROI} : start y position of ROI
- (x,y): position in frame
- A_f : Amplitude of f_{th} frame
- D_f : Depth of f_{th} frame
- D_f^{Fit} : Fitted plane of f_{th} frame

Color



• Temporal stability of the ToF system



Calculation

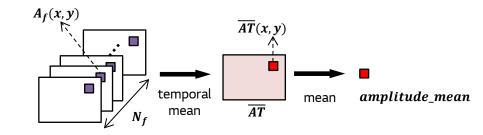
• dA(x,y) = temporal standard deviation of the amplitudes of single pixel, $A_f(x,y)$

$$dA(x,y) = \sqrt{\frac{1}{N_f} \sum_{f=1}^{N_f} (A_f(x,y) - \overline{AT}(x,y))^2}$$

• $amplitude_std = mean of dA_f$

$$amplitude_std = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} dA(x, y)$$

- Modulated signal strength of ToF system
- amplitude_max: the best performing pixel
- · amplitude_min: the worst performing pixel



Calculation

• $\overline{AT}(x,y)$ = temporal average of the amplitudes of single pixel, $A_f(x,y)$

$$\overline{AT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} A_f(x,y)$$

• $amplitude_mean = mean of \overline{AT}$

$$amplitude_mean = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} \overline{AT}(x, y)$$

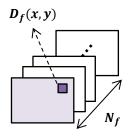
• $amplitude_min = min of \overline{AT}$

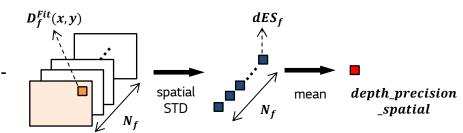
$$amplitude_min = min\{\overline{AT}\}$$

• $amplitude_max = max \text{ of } \overline{AT}$

$$amplitude_max = max\{\overline{AT}\}$$

· Spatial noise of the depth error





Calculation

• $\overline{\mathit{ES_fit}}_f$ = spatial average of the depth error for frame

$$\overline{ES_fit}_f = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} (D_f(x, y) - D_f^{Fit}(x, y))$$

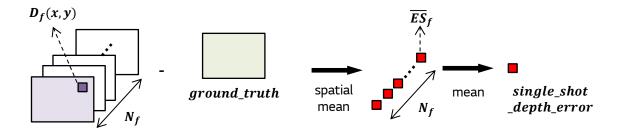
dES = spatial standard deviation of the depth error for frame

$$dES_f = \sqrt{\frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} ((D_f(x,y) - D_f^{Fit}(x,y)) - \overline{ES_fit}_f)^2}$$

• depth_precision_spatial = mean of the dES

$$depth_precision_spatial = \frac{1}{N_f} \sum_{f=1}^{N_f} dES_f$$

- Reliability of the depth measurement
- Spatial depth error



Calculation

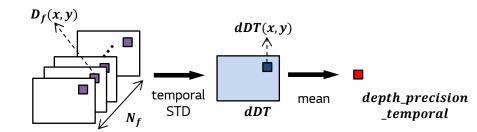
• \overline{ES}_f = spatial average of the depth error for frame

$$\overline{ES}_f = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} (D_f(x, y) - -ground_truth)$$

• $single_shot_depth_error$ = mean of the \overline{ES}_f

$$single_shot_depth_error = \frac{1}{N_f} \sum_{f=1}^{N_f} \overline{ES}_f$$

• Temporal noise of the depth values



Calculation

• $\overline{DT}(x,y)$ = temporal average of the calculated depth of single pixel, $D_f(x,y)$

$$\overline{DT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} D_f(x,y)$$

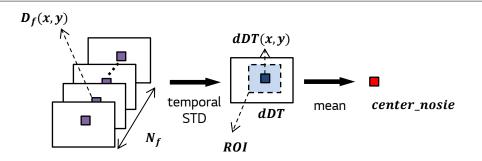
• dDT(x,y) = temporal standard deviation of the calculated depth of single pixel, $D_f(x,y)$

$$dDT(x,y) = \sqrt{\frac{1}{N_f} \sum_{f=1}^{N_f} \left(D_f(x,y) - \overline{DT}(x,y) \right)^2}$$

• depth_precision_temporal = mean of the dDT

$$depth_precision_temporal = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} dDT(x, y)$$

- Temporal noise of the depth values in ROI
- ROI: center 5x5



Calculation

• $\overline{DT}(x,y)$ = temporal average of the calculated depth of single pixel, $D_f(x,y)$

$$\overline{DT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} D_f(x,y)$$

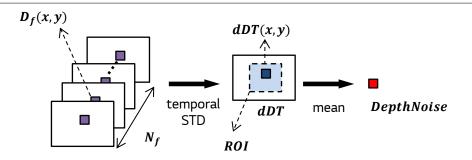
• dDT(x,y) = temporal standard deviation of the calculated depth of single pixel, $D_f(x,y)$

$$dDT(x,y) = \sqrt{\frac{1}{N_f} \sum_{f=1}^{N_f} \left(D_f(x,y) - \overline{DT}(x,y) \right)^2}$$

• center_noise = mean of the dDT in ROI

$$center_noise = \frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} dDT(x,y)$$

- Temporal noise of the depth values
- ROI: center 10x10



Calculation

• $\overline{DT}(x,y)$ = temporal average of the calculated depth of single pixel, $D_f(x,y)$

$$\overline{DT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} D_f(x,y)$$

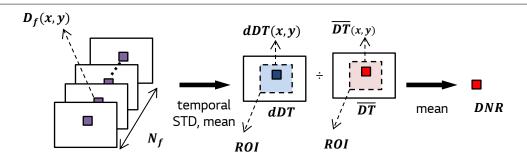
• dDT(x,y) = temporal standard deviation of the calculated depth of single pixel, $D_f(x,y)$

$$dDT(x,y) = \sqrt{\frac{1}{N_f} \sum_{f=1}^{N_f} (D_f(x,y) - \overline{DT}(x,y))^2}$$

DepthNoise = mean of the dDT

$$DepthNoise = \frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} dDT(x,y)$$

- DNR = Depth Noise Ratio
- ROI: center 10x10



Calculation

• rDT(x, y) = relative of temporal mean and standard deviation of single pixel

$$rDT(x,y) = \frac{dDT(x,y)}{\overline{DT}(x,y)}$$

$$DNR = \frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} rDT(x,y) * 100$$

- DNNU = Depth Noise Ratio Non-Uniformity
- ROI: center 50x50

$D_f(x,y)$ DT(x,y) DT(

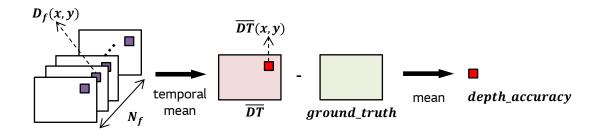
Calculation

• DNNU(x, y) = noise of DNR in ROI

$$DNR = \frac{1}{w_{ROI}h_{ROI}} \sum_{x_{ROI}=1}^{w_{ROI}} \sum_{y_{ROI}=1}^{h_{ROI}} rDT(x, y)$$

$$DNNU = \sqrt{\frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} (rDT(x,y) - DNR)^2}$$

· Reliability of the depth measurement



Calculation

• $\overline{DT}(x,y)$ = temporal average of the calculated depth of single pixel, $D_f(x,y)$

$$\overline{DT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} D_f(x,y)$$

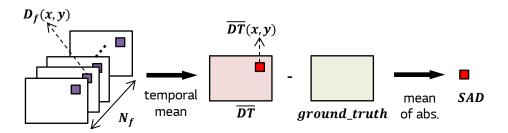
depth_accuracy = mean of difference between temporal average and ground truth

$$depth_accuracy = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} (\overline{DT}(x, y) - ground_truth)$$

• *depth_accuracy_percent* = the relative depth error

$$depth_accuracy_percent = \frac{depth_accuracy}{ground_truth}$$

- Reliability of the depth measurement
- Sum of absolute difference error



Calculation

• $\overline{DT}(x,y)$ = temporal average of the calculated depth of single pixel, $D_f(x,y)$

$$\overline{DT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} D_f(x,y)$$

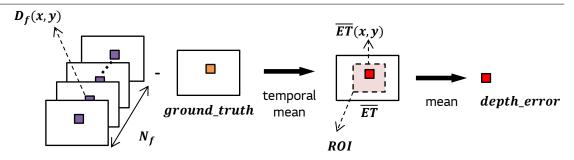
• SAD = mean of absolute difference between temporal average and ground truth

$$SAD = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} |\overline{DT}(x,y) - ground_truth|$$

• SAD10 = mean of absolute difference between temporal average and ground truth in ROI 10x10

$$SAD10 = \frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} |\overline{DT}(x,y) - ground_truth|$$

- Reliability of the depth measurement
- ROI: center 10x10



Calculation

• $\overline{ET}(x,y)$ = temporal average of depth error of single pixel

$$\overline{ET}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} (D_f(x,y) - ground_truth)$$

• $DepthError = mean of \overline{ET} in ROI$

$$DepthError = \frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} \overline{ET}(x,y)$$

- DENU = Depth Error Non-Uniformity
- · Temporal noise of the depth error
- ROI: center 50x50

$D_f(x,y)$ $\overline{ET}(x,y)$ STD DENU ROI

Calculation

• DENU =standard deviation \overline{ET} in ROI

$$DepthError = \frac{1}{w_{ROI}h_{ROI}} \sum_{x=x_{ROI}}^{w_{ROI}} \sum_{y=y_{ROI}}^{h_{ROI}} \overline{ET}(x,y)$$

$$DENU = \sqrt{\frac{1}{w_{ROI}h_{ROI}}\sum_{x=x_{ROI}}^{w_{ROI}}\sum_{y=y_{ROI}}^{h_{ROI}}(\overline{ET}(x,y) - DepthError)^2}$$

대외비 2급

Description

- the number of pixels that can be used for the measurement
- masking pixels with insufficient lighting and defect pixels

Calculation

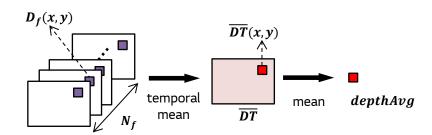
$$number_of_calibrated_pixels = \frac{1}{w_{ROI}h_{ROI}}\sum_{x=x_{ROI}}^{w_{ROI}}\sum_{y=y_{ROI}}^{h_{ROI}} \sim Mask(x,y)$$

• Ratio of valid_pixels in ROI

Calculation

$$valid_pixels_percentage = \frac{1}{w_{ROI}h_{ROI}}number_of_calibrated_pixels$$

• Reliability of the depth measurement



Calculation

• $\overline{DT}(x,y)$ = temporal average of the calculated depth of single pixel, $D_f(x,y)$

$$\overline{DT}(x,y) = \frac{1}{N_f} \sum_{f=1}^{N_f} D_f(x,y)$$

• $depthAvg = mean of \overline{DT}$

$$depthAvg = \frac{1}{wh} \sum_{x=1}^{w} \sum_{y=1}^{h} \overline{DT}(x, y)$$

• $depthMin = min of \overline{DT}$

$$depthMin = min\{\overline{DT}\}$$

• $depthMax = max of \overline{DT}$

$$depthMax = max\{\overline{DT}\}$$

• Fitted plane using calibrated 3D point cloud

Calculation

• Hessian Normal Plane form [n, d]

$$n_1x + n_2y + n_3z = d$$

• X,Y,Z = calibrated 3D point cloud

$$X = [x_1, \dots, x_{wh}], Y = [y_1, \dots, y_{wh}], Z = [z_1, \dots, z_{wh}]$$

• Fitted plane [n, d]

$$\begin{bmatrix} a_1 \\ a_2 \\ a_3 \end{bmatrix} = \begin{bmatrix} x_1 & y_1 & 1 \\ \vdots & \vdots & \vdots \\ x_{wh} & y_{wh} & 1 \end{bmatrix}^{-1} \begin{bmatrix} z_1 \\ \vdots \\ z_{wh} \end{bmatrix}$$

$$n_{-}=\left[-\frac{a_1}{a_3},-\frac{a_2}{a_3},\frac{1}{a_1}\right]$$

$$d = 1/norm(n_{-})$$
$$n = n_{-} * d$$

• Distance of points to plane (plane error)

$$PE = \begin{bmatrix} x_1 & y_1 & z_1 \\ \vdots & \vdots & \vdots \\ x_{wh} & y_{wh} & z_{wh} \end{bmatrix} \begin{bmatrix} n_1 \\ n_2 \\ n_3 \end{bmatrix} - \begin{bmatrix} d \\ \vdots \\ d \end{bmatrix}$$

• Plane error max = max value of *PE*

$$plane_error_max = max\{PE\}$$

• Plane error mean = average of **PE**

$$plane_error_mean = \frac{1}{wh} \sum_{i=1}^{wh} PE(i)$$

• Plane error std= standard deviation of PE

$$plane_error_std = \sqrt{\frac{1}{wh} \sum_{i=1}^{wh} (PE(i) - plane_error_mean)^2}$$

- the top 10 percent of plane fit error
- indicator plane error of the relative deviation

Calculation

• Q90norm = the top 10 percent of normalized plan fit error

$$PE_{norm} = \frac{PE}{d}$$

$$PE_{sort} = sort(PE_{norm}, 'ascend')$$

$$Q90norm = PE_{sort}(wh * 0.9)$$

대외비 2급

Description

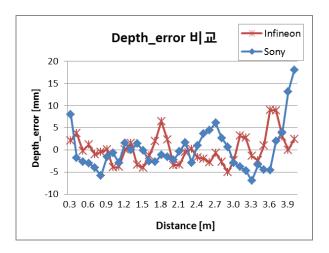
- Tilt: angle of plane fit about y-axis
- Pan: angle of plane fit about x-axis

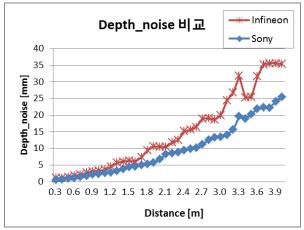
Calculation

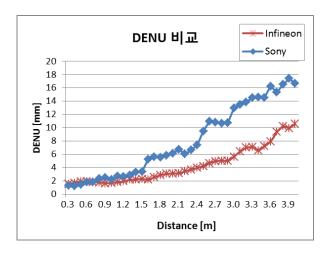
• Fitted plane [*n*, *d*]

```
Plane Tilt = 90^{\circ} - acosd(n_1)
Plane Pan = 90^{\circ} - acosd(n_2)
```

- 동합 Calibration으로 사용하지 않고, 각 사의 방식으로 calibration한 결과
- Test sample
 - Infineon : PP1 10ea 중 best (8270-88B2-1AC2-4484), 80M & 60M dual
 - Sony (Cat tree): PP2 19ea 중 best (S08), 100M & 60M dual
- 각 test 모듈 중 Best 샘플 1개씩으로 대표 비교
- Sony 가 사용하는 Minikit 으로는 amplitude를 구할 수 없는 구조라서 depth만 비교

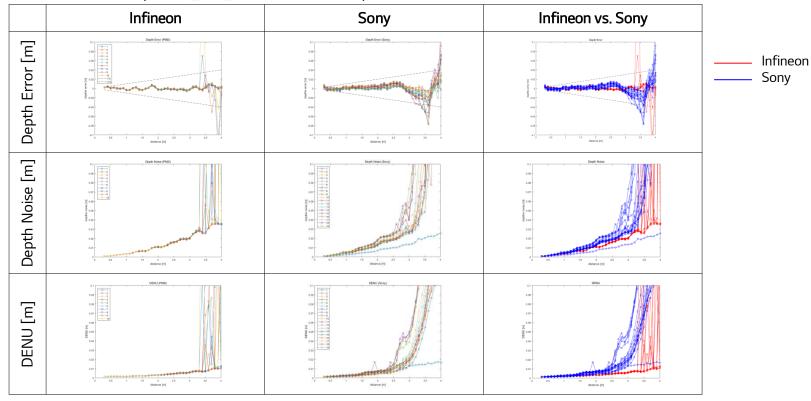






- ➤ Depth error 는 비슷한 수준
- ➤ Depth noise 는 Sony가 더 좋음
- ➤ DENU(uniformity) 는 Infineon이 더 좋음

- 동합 Calibration으로 사용하지 않고, 각 사의 방식으로 calibration한 결과
- Test sample
 - Infineon: PP1 10ea 전체, 80M & 60M dual
 - Sony (Cat tree): PP2 19ea 전체, 100M & 60M dual
- Sony 가 사용하는 Minikit 으도는 amplitude를 구할 수 없는 구조라서 depth만 비교



- ➤ 샘플별 편차는 모든 항목에서 Infineon이 우수함
- ➤ Depth Error : 동등 수준
 - ➤ PMD의 Spectre가 적용된다면 Infineon의 성능은 더 좋을 수 있음 (alpha 성능)
- > Depth Noise (temporal uniformity): Infineon이 우수함 (best는 Sony가 좋았음, 앞장 참고)
- ➤ DENU (spatial uniformity): Infineon이 우수함